

STP16NF06L

N-CHANNEL 60V - 0.07 Ω - 16A TO-220 STripFETTM POWER MOSFET

TYPE	V _{DSS}	RDS(on)	ΙD
STP16NF06L	60 V	<0.09 Ω	16 A

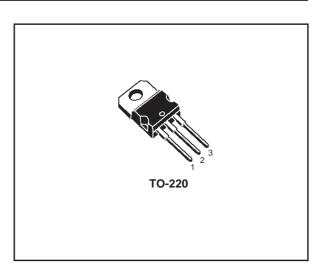
- TYPICAL $R_{DS}(on) = 0.07\Omega$
- EXCEPTIONAL dv/dt CAPABILITY
- LOW GATE CHARGE AT 100 °C
- LOW THRESHOLD DRIVE

DESCRIPTION

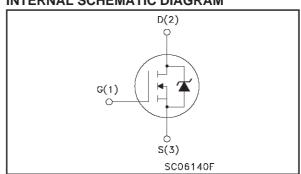
This Power MOSFET is the latest development of STMicroelectronis unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

APPLICATIONS

- MOTOR CONTROL, AUDIO AMPLIFIERS
- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- DC-DC & DC-AC CONVERTERS
- AUTOMOTIVE ENVIRONMENT



INTERNAL SCHEMATIC DIAGRAM



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source Voltage (V _{GS} = 0)	60	V
V _{DGR}	Drain-gate Voltage ($R_{GS} = 20 \text{ k}\Omega$)	60	V
Vgs	Gate- source Voltage	± 16	V
I _D	Drain Current (continuos) at T _C = 25°C	16	А
I _D	Drain Current (continuos) at T _C = 100°C	11	А
I _{DM} (●)	Drain Current (pulsed)	64	Α
P _{tot}	Total Dissipation at T _C = 25°C	45	W
	Derating Factor	0.3	W/°C
dv/dt (1)	Peak Diode Recovery voltage slope	23	V/ns
E _{AS} (2)	Single Pulse Avalanche Energy	127	mJ
T _{stg}	Storage Temperature	-65 to 175	°C
Tj	Max. Operating Junction Temperature	-55 to 175	°C

^(•) Pulse width limited by safe operating area.

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⁽¹⁾ IsD \leq 16A, di/dt \leq 210A/µs, VDD \leq V(BR)DSS, T_{j} \leq T_{JMAX} (2) Starting T_{j} = 25 °C, ID = 8A, VDD = 30V

THERMAL DATA

	Thermal Resistance Junction-case Thermal Resistance Junction-ambient Maximum Lead Temperature For Soldering Purpose	Max Max Typ	3.33 62.5 300	°C/W °C/W °C	
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ELECTRICAL CHARACTERISTICS ($T_{case} = 25 \, ^{\circ}C$ unless otherwise specified)

OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0$	60			V
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	$V_{DS} = Max Rating$ $V_{DS} = Max Rating T_{C} = 125^{\circ}C$			1 10	μA μA
I _{GSS}	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 16V			±100	nA

ON (1)

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$	$I_D = 250 \mu\text{A}$	1			V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} = 5 V V _{GS} = 10 V	I _D = 8 A I _D = 8 A		0.08 0.07	0.10 0.09	Ω

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
g _{fs} (*)	Forward Transconductance	$V_{DS} > I_{D(on)} \times R_{DS(on)max},$ $I_{D} = 8 \text{ A}$		17		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25V, f = 1 \text{ MHz}, V_{GS} = 0$		345 72 29		pF pF pF

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ELECTRICAL CHARACTERISTICS (continued)

SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
td(on) t _r	Turn-on Delay Time Rise Time	$\begin{aligned} &V_{DD} = 30 \text{ V} & I_{D} = 8 \text{ A} \\ &R_{G} = 4.7 \Omega & V_{GS} = 4.5 \text{ V} \\ &(\text{Resistive Load, Figure 3}) \end{aligned}$		10 37		ns ns
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	V _{DD} = 48 V I _D = 16 A V _{GS} = 5V		7.3 2.1 3.1	10	nC nC nC

SWITCHING OFF

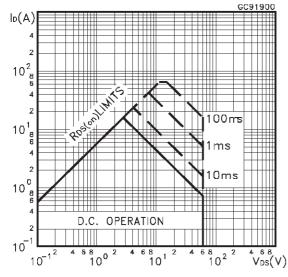
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(off)} t _f	Turn-off Delay Time Fall Time	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$		20 12.5		ns ns

SOURCE DRAIN DIODE

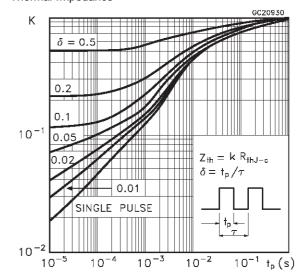
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain Current Source-drain Current (pulsed)				16 64	A A
V _{SD} (*)	Forward On Voltage	I _{SD} = 16 A V _{GS} = 0			1.3	V
t _{rr} Q _{rr} IRRM	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$\begin{split} I_{SD} = 16 \text{ A} & \text{di/dt} = 100 \text{A}/\mu \text{s} \\ V_{DD} = 16 \text{ V} & T_j = 150^{\circ} \text{C} \\ \text{(see test circuit, Figure 5)} \end{split}$		50 67.5 2.7		ns nC A

^(*)Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %.
(•)Pulse width limited by safe operating area.

Safe Operating Area

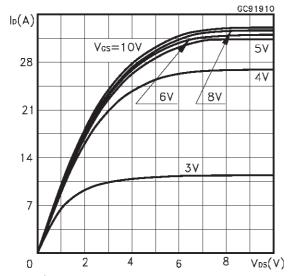


Thermal Impedance

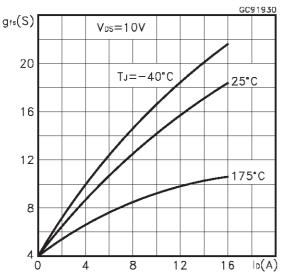


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Output Characteristics

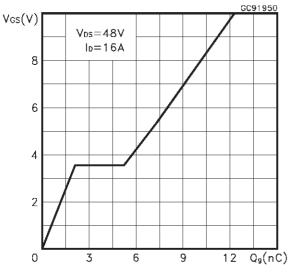


Transconductance

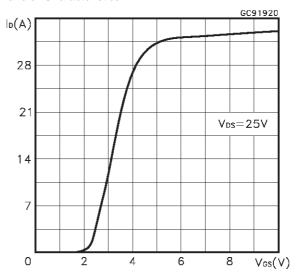


Gate Charge vs Gate-source Voltage

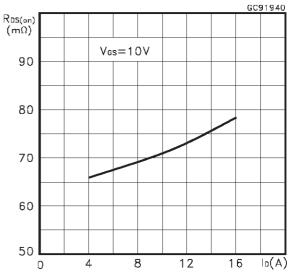
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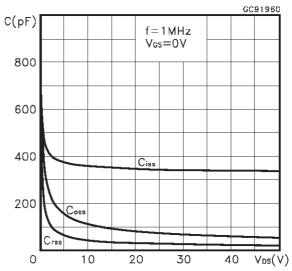
Transfer Characteristics



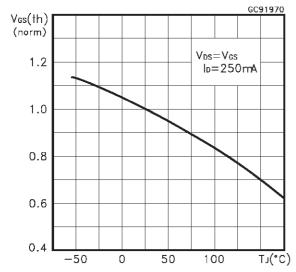
Static Drain-source On Resistance



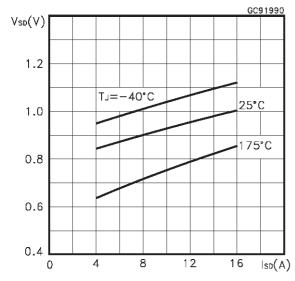
Capacitance Variations



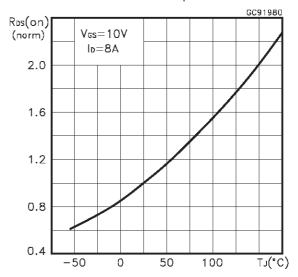
Normalized Gate Threshold Voltage vs Temperature



Source-drain Diode Forward Characteristics



Normalized on Resistance vs Temperature



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Fig. 1: Unclamped Inductive Load Test Circuit

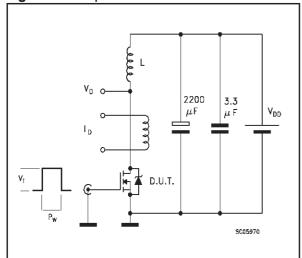


Fig. 3: Switching Times Test Circuits For Resistive Load

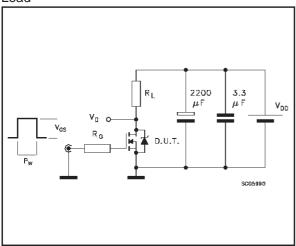


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times

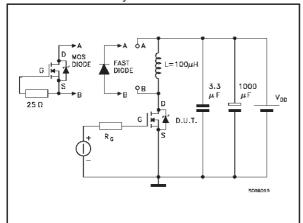


Fig. 2: Unclamped Inductive Waveform

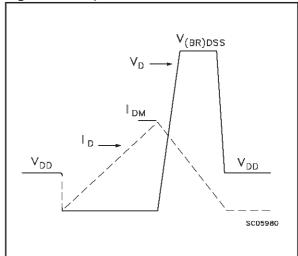
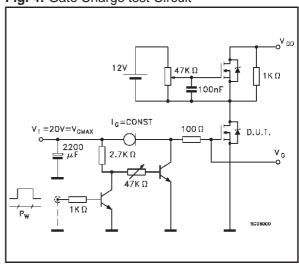


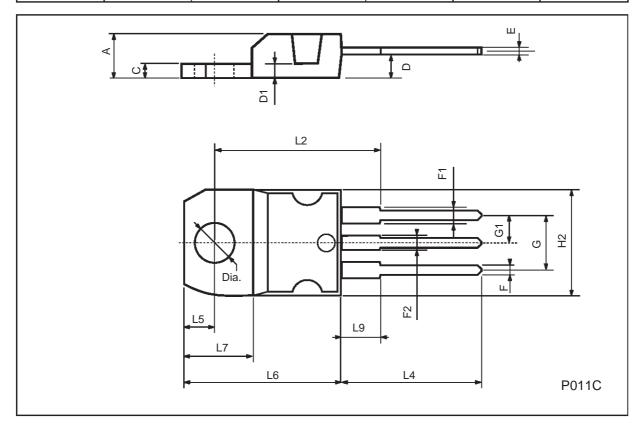
Fig. 4: Gate Charge test Circuit



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TO-220 MECHANICAL DATA

DIM.		mm		inch			
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А	4.40		4.60	0.173		0.181	
С	1.23		1.32	0.048		0.051	
D	2.40		2.72	0.094		0.107	
D1		1.27			0.050		
Е	0.49		0.70	0.019		0.027	
F	0.61		0.88	0.024		0.034	
F1	1.14		1.70	0.044		0.067	
F2	1.14		1.70	0.044		0.067	
G	4.95		5.15	0.194		0.203	
G1	2.4		2.7	0.094		0.106	
H2	10.0		10.40	0.393		0.409	
L2		16.4			0.645		
L4	13.0		14.0	0.511		0.551	
L5	2.65		2.95	0.104		0.116	
L6	15.25		15.75	0.600		0.620	
L7	6.2		6.6	0.244		0.260	
L9	3.5		3.93	0.137		0.154	
DIA.	3.75		3.85	0.147		0.151	



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